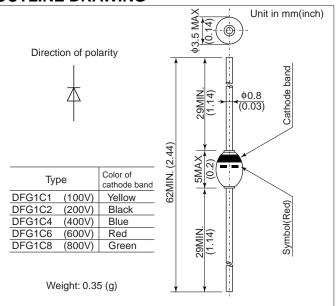


FEATURES

- For high speed switching.
- Diffused-junction. Glass passivated and encapsulated.

OUTLINE DRAWING



ABSOLUTE MAXIMUM RATINGS

Items	Туре		DFG1C1	DFG1C2	DFG1C4	DFG1C6	DFG1C8		
Repetitive Peak Reverse Voltage	V _{RRM}	V	100	200	400	600	800		
Average Forward Current	I _{F(AV)}	А		1.0(TL=80°C	1.0(TL=70°C)				
			(Single-phase half sine wave 180° conduction, Lead length = 10mm)						
Surge(Non-Repetitive) Forward Current	I _{FSM}	А		35	30				
			(Without PIV, 10ms conduction, Tj = $150^{\circ}C$ start)						
I ² t Limit Value	l ² t	A ² s	4.9			3.6			
			(Time = 2 ~ 10ms, I = RMS value)						
Operating Junction Temperature	Tj	°C	-65 ~ +150						
Storage Temperature	T _{stg}	°C	-65 ~ +150						

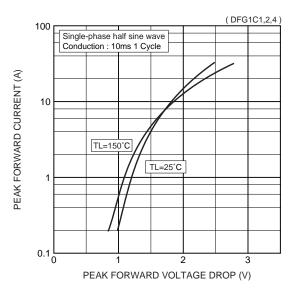
Notes (1) Lead mounting : Lead temperature 300°C max. to 3.2mm from body for 5sec. max.. (2) Mechanical strength : Bending 90°×2 cycles or 180°×1 cycle, Tensile 2kg, Twist 90°×1 cycle.

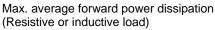
CHARACTERISTICS(T_L=25°C)

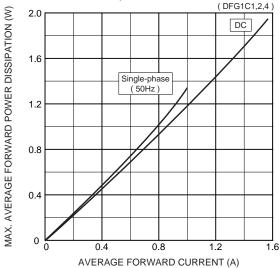
Items	Symbols	Units	Min.	Тур.	Max.	Test Conditions		
Peak Reverse Current	I _{RRM}	μA	_	_	10	Rated V_{RRM}		
Peak Forward Voltage	V _{FM}	V	—	_	1.2	DFG1C1,2,4	I _{FM} =1.0Ap, Single-phas	
			_	_	1.6	DFG1C6,8	half sine wave 1 cycle	
Reverse Recovery Time	trr	μs	_	_	0.1	I _F =0.5A, I _{rp} =1.0A, 25% Recovery		
Steady State Thermal Impedance	R _{th(j-a)}	°C/W	_	_	80	Lead length = 10 mm		
	R _{th(j-l)}				50			

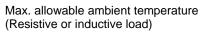
DFG1C

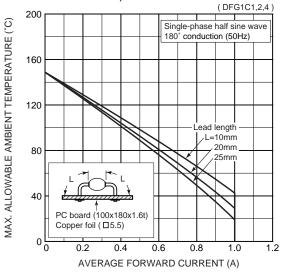
Forward characteristics



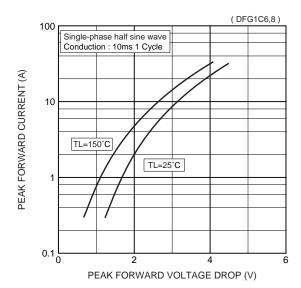




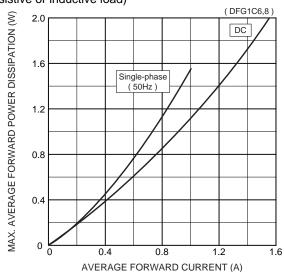




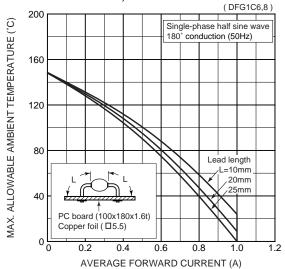
Forward characteristics



Max. average forward power dissipation (Resistive or inductive load)



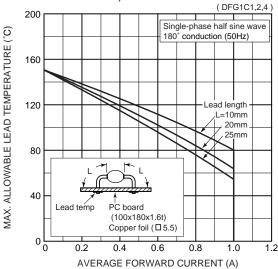
Max. allowable ambient temperature (Resistive or inductive load)

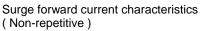


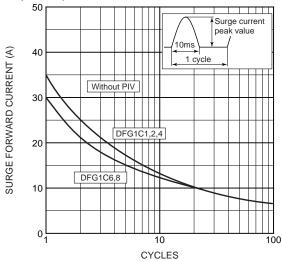
HITACHI

DFG1C

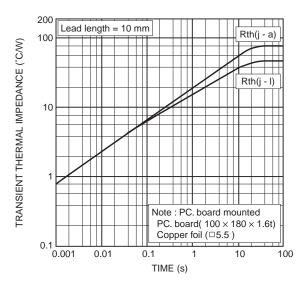
Max. allowable lead temperature (Resistive or inductive load)



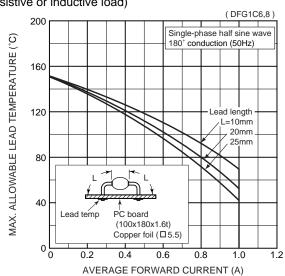




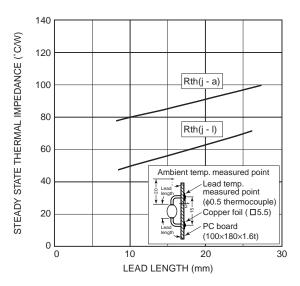
Transient thermal impedance



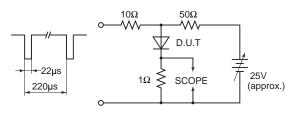
Max. allowable lead temperature (Resistive or inductive load)

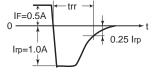


Steady state thermal impedance



Reverse recovery time (trr) test circuit





HITACHI

Precautions for Safe Use and Notices

If semiconductor devices are handled inappropriate manner, failures may result. For this reason, be sure to read "Precaution for Use" before use.



This mark indicates an item about which caution is required.

CAUTION This mark indicates a potentially hazardous situation which, if not avoided, may result in minor or moderate injury and damage to property.

\triangle CAUTION

- (1) Regardless of changes in external conditions during use "absolute maximum ratings" should never be exceed in designing electronic circuits that employ semiconductors. In the case of pulse use, furthermore, "safe operating area(SOA)" precautions should be observed.
- (2) Semiconductor devices may experience failures due to accident or unexpected surge voltages. Accordingly, adopt safe design features, such as redundancy or prevention of erroneous action, to avoid extensive damage in the event of a failure.
- (3) In cases where extremely high reliability is required (such as use in nuclear power control, aerospace and aviation, traffic equipment, life-support-related medical equipment, fuel control equipment and various kinds of safety equipment), safety should be ensured by using semiconductor devices that feature assured safety or by means of user's fail-safe precautions or other arrangement. Or consult Hitachi's sales department staff.

(If a semiconductor device fails, there may be cases in which the semiconductor device, wiring or wiring pattern will emit smoke or cause a fire or in which the semiconductor device will burst)

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